

N-channel MOS-FET			
800V	1,5Ω	9A	100W

> **Features**

- High Speed Switching
- Low On-Resistance
- No Secondary Breakdown
- Low Driving Power
- High Voltage
- $V_{GS} = \pm 30V$  Guarantee
- Repetitive Avalanche Rated

> **Applications**

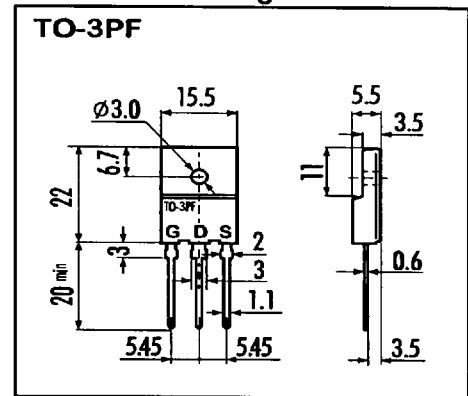
- Switching Regulators
- UPS
- DC-DC converters
- General Purpose Power Amplifier

> **Maximum Ratings and Characteristics**

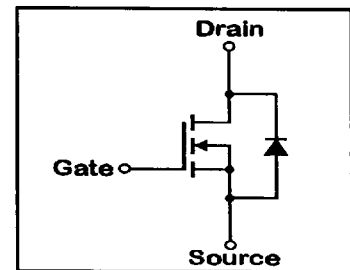
- Absolute Maximum Ratings( $T_C=25^\circ C$ ) unless otherwise specified

Item	Symbol	Rating	Unit
Drain-Source-Voltage	$V_{DS}$	800	V
Continuous Drain Current	$I_D$	9	A
Pulsed Drain Current	$I_{D(puls)}$	36	A
Gate-Source-Voltage	$V_{GS}$	$\pm 30$	V
Repetitive or Non-Repetitive ( $T_{ch} \leq 150^\circ C$ )	$I_{AR}$	9	A
Avalanche Energy	$E_{AS}$	141	mJ
Max. Power Dissipation	$P_D$	100	W
Operating and Storage Temperature Range	$T_{ch}$	150	$^\circ C$
	$T_{stg}$	-55 ~ +150	$^\circ C$

> **Outline Drawing**



> **Equivalent Circuit**



- Electrical Characteristics ( $T_C=25^\circ C$ ) unless otherwise specified

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown-Voltage	$V_{(BR)DSS}$	$I_D=1mA$ $V_{GS}=0V$	800			V
Gate Threshold Voltage	$V_{GS(th)}$	$I_D=1mA$ $V_{DS}=V_{GS}$	3,5	4,0	4,5	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS}=800V$ $T_{ch}=25^\circ C$		10	500	$\mu A$
		$V_{GS}=0V$ $T_{ch}=125^\circ C$		0,2	1,0	mA
Gate Source Leakage Current	$I_{GSS}$	$V_{GS}=\pm 30V$ $V_{DS}=0V$		10	100	nA
Drain Source On-State Resistance	$R_{DS(on)}$	$I_D=4,5A$ $V_{GS}=10V$		1,28	1,50	$\Omega$
Forward Transconductance	$g_{fs}$	$I_D=4,5A$ $V_{DS}=25V$		6		S
Input Capacitance	$C_{iss}$	$V_{DS}=25V$		1200		pF
Output Capacitance	$C_{oss}$	$V_{GS}=0V$		180		pF
Reverse Transfer Capacitance	$C_{rss}$	$f=1MHz$		90		pF
Turn-On-Time $t_{on}$ ( $t_{on}=t_{d(on)}+t_r$ )	$t_{d(on)}$	$V_{CC}=600V$		30		ns
	$t_r$	$I_D=9A$		120		ns
Turn-Off-Time $t_{off}$ ( $t_{off}=t_{d(off)}+t_f$ )	$t_{d(off)}$	$V_{GS}=10V$		95		ns
	$t_f$	$R_{GS}=10 \Omega$		60		ns
Avalanche Capability	$I_{AV}$	$L=100\mu H$ $T_{ch}=25^\circ C$	9,0			A
Diode Forward On-Voltage	$V_{SD}$	$I_F=2I_{DR}$ $V_{GS}=0V$ $T_{ch}=25^\circ C$		1,0		V
Reverse Recovery Time	$t_{rr}$	$I_F=I_{DR}$ $V_{GS}=0V$		900		ns
Reverse Recovery Charge	$Q_{rr}$	$-di_F/dt=100A/\mu s$ $T_{ch}=25^\circ C$		12		$\mu C$

- Thermal Characteristics

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance	$R_{th(ch-a)}$	channel to air			30	$^\circ C/W$
	$R_{th(ch-c)}$	channel to case			1,25	$^\circ C/W$

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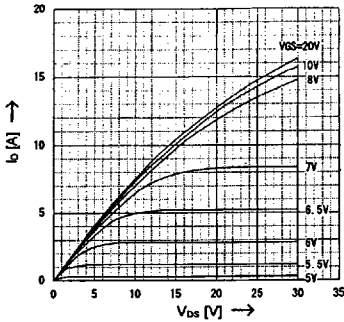
# 2SK2649-01R

## FAP-IIS Series

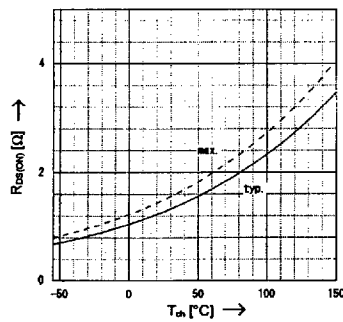


### > Characteristics

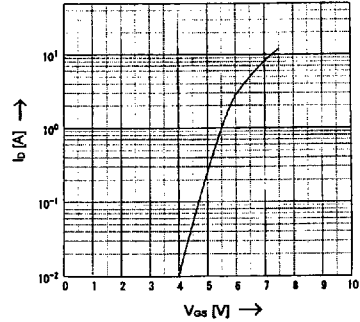
Typical Output Characteristics  
 $I_D = f(V_{DS})$ ; 80μs pulse test;  $T_C = 25^\circ\text{C}$



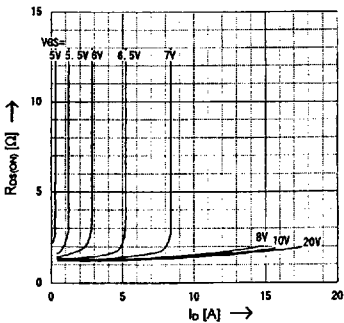
Drain-Source On-State Resistance vs.  $T_{ch}$   
 $R_{DS(on)} = f(T_{ch})$ ;  $I_D = 4.5\text{A}$ ;  $V_{GS} = 10\text{V}$



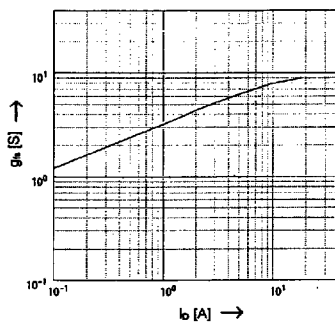
Typical Transfer Characteristics  
 $I_D = f(V_{GS})$ ; 80μs pulse test;  $V_{DS} = 25\text{V}$ ;  $T_C = 25^\circ\text{C}$



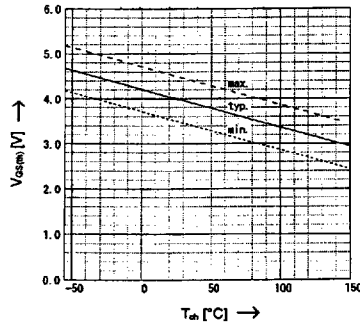
Typical Drain-Source On-State-Resistance vs.  $I_D$   
 $R_{DS(on)} = f(I_D)$ ; 80μs pulse test;  $T_C = 25^\circ\text{C}$



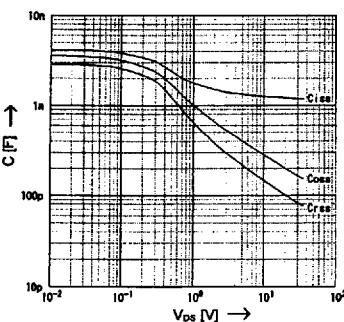
Typical Forward Transconductance vs.  $I_D$   
 $g_m = f(I_D)$ ; 80μs pulse test;  $V_{GS} = 25\text{V}$ ;  $T_C = 25^\circ\text{C}$



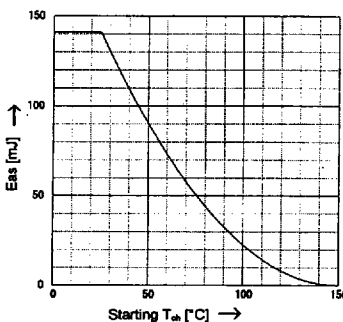
Gate Threshold Voltage vs.  $T_{ch}$   
 $V_{GS(th)} = f(T_{ch})$ ;  $I_D = 1\text{mA}$ ;  $V_{DS} = V_{GS}$



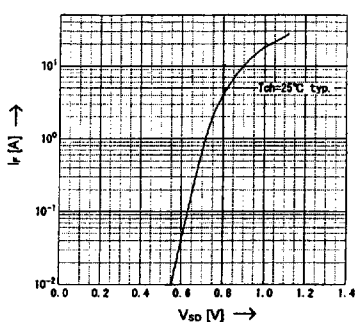
Typical Capacitances vs.  $V_{DS}$   
 $C = f(V_{DS})$ ;  $V_{GS} = 0\text{V}$ ;  $f = 1\text{MHz}$



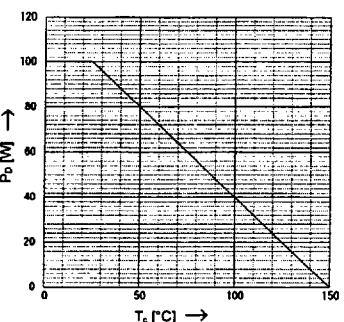
Avalanche Energy Derating  
 $E_{AS} = f(\text{starting } T_{ch})$ ;  $V_{CC} = 80\text{V}$ ;  $I_{AS} = 9\text{A}$



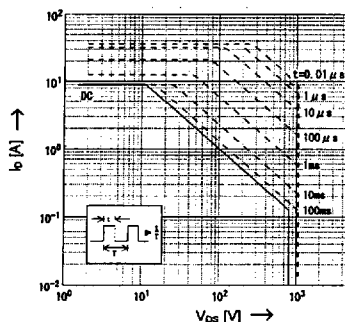
Forward Characteristics of Reverse Diode  
 $I_F = f(V_{SD})$ ; 80μs pulse test;  $V_{GS} = 0\text{V}$



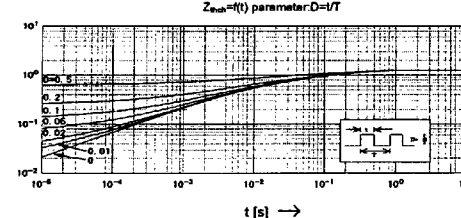
Allowable Power Dissipation vs.  $T_C$   
 $P_D = f(T_C)$



Safe Operation Area  
 $I_D = f(V_{DS})$ ;  $D = 0,01$ ;  $T_C = 25^\circ\text{C}$



Transient Thermal Impedance  
 $Z_{th(jc)} = f(t)$  parameter:  $D = t/T$



This specification is subject to change without notice.

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